

# 1 Channel Compact High Side Switch ICs

# 1.0A Current Limit High Side Switch ICs

# BD2240G BD2241G

### **General Description**

BD2240G and BD2241G are low ON-Resistance high-side power switches N-Channel MOSFETs for Universal Serial Bus (USB) applications. These ICs have built-in over-current protection, thermal shutdown, under-voltage lockout and soft-start.

#### **Features**

- Built-in Low ON-Resistance (Typ 110m $\Omega$ ) N-Channel MOSFET
- **Over-Current Detection**
- Thermal Shutdown
- Open-Drain Fault Flag Output
- Flag Output Delay
- Under-Voltage Lockout
- Soft-Start Circuit
- **Output Discharge Function**
- Reverse Current Protection when
- Power Switch Off Control Input Logic

Active-High: BD2240G Active-Low: BD2241G

# **Applications**

USB Hub in Consumer Appliances, PC, PC Peripheral Equipment, and so forth

### **Key Specifications**

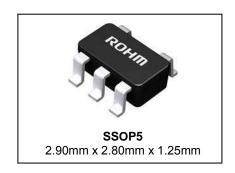
■ Input Voltage Range: 2.7V to 5.5V ON-Resistance:  $110m\Omega(Typ)$ 

Over-Current Threshold: 0.82A (Min), 1.12A (Max)

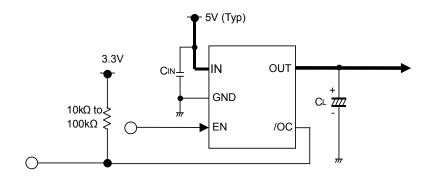
Standby Current:  $0.01\mu A (Typ)$ -40°C to +85°C

Operating Temperature Range:

### Package W(Typ) D(Typ) H (Max)



# **Typical Application Circuit**

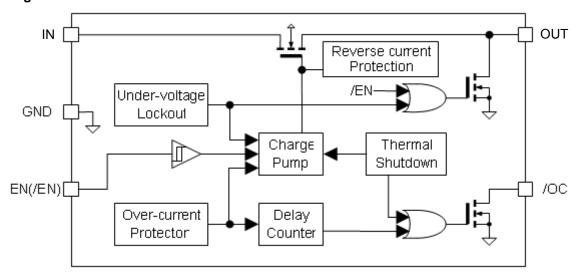


# Lineup

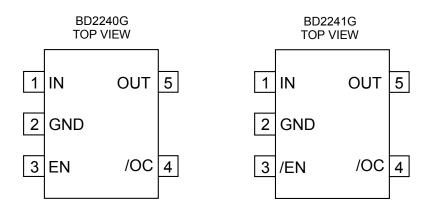
Ove	Over-Current Threshold			В	aakaaa	Orderable Part Number
Min	Тур	Max	Logic	Package		Orderable Part Number
0.82A	0.97A	1.12A	High	SSOP5	Reel of 3000	BD2240G-GTR
0.82A	0.97A	1.12A	Low	SSOP5	Reel of 3000	BD2241G-GTR

OProduct structure: Silicon monolithic integrated circuit OThis product has not designed protection against radioactive rays

# **Block Diagram**



# **Pin Configurations**



# **Pin Description**

Pin No.	Symbol	I/O	Function
1	IN	-	Switch input and the supply voltage for the IC
2	GND	-	Ground
3	EN, /EN	I	Enable input EN: High level input turns on the switch. (BD2240G) /EN: Low level input turns on the switch. (BD2241G)
4	/OC	0	Over-current detection terminal.  Low level output during over-current or over-temperature condition  Open-drain fault flag output
5	OUT	0	Switch output

Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Rating	Unit
IN Supply Voltage	V <sub>IN</sub>	-0.3 to +6.0	V
EN(/EN) Input Voltage	$V_{EN}, V_{/EN}$	-0.3 to +6.0	V
/OC Voltage	V <sub>/OC</sub>	-0.3 to +6.0	V
/OC Sink Current	I <sub>/OC</sub>	5	mA
OUT Voltage	V <sub>OUT</sub>	-0.3 to +6.0	V
Storage Temperature	Tstg	-55 to +150	°C
Power Dissipation	Pd	0.67 <sup>(Note 1)</sup>	W

(Note 1) Mounted on 70mm x 70mm x 1.6mm glass epoxy board. Reduce 5.4mW per 1°C above 25°C

Caution: Operating the IC over the absolute maximum ratings may damage the IC. The damage can either be a short circuit between pins or an open circuit between pins and the internal circuitry. Therefore, it is important to consider circuit protection measures, such as adding a fuse, in case the IC is operated over the absolute maximum ratings.

**Recommended Operating Conditions** 

Darameter	Cumbal	Rating			Linit
Parameter	Symbol	Min	Тур	Max	Unit
IN Operating Voltage	V <sub>IN</sub>	2.7	5.0	5.5	V
Operating Temperature	Topr	-40	-	+85	°C

### **Electrical Characteristics**

BD2240G (V<sub>IN</sub>= 5V, Ta= 25°C, unless otherwise specified.)

DC Characteristics

Darameter	Cumahal		Limit		l lait	Conditions	
Parameter	Symbol	Min	Тур	Max	Unit		
Operating Current	I <sub>DD</sub>	-	110	160	μΑ	V <sub>EN</sub> = 5V, V <sub>OUT</sub> = open	
Standby Current	I <sub>STB</sub>	-	0.01	5	μA	V <sub>EN</sub> = 0V, V <sub>OUT</sub> = open	
EN Input Voltage	V <sub>ENH</sub>	2.0	-	-	V	High Input	
EN Input Voltage	V <sub>ENL</sub>	-	-	8.0	V	Low Input	
EN Input Leakage	I <sub>EN</sub>	-1	+0.01	+1	μΑ	V <sub>EN</sub> = 0V or 5V	
ON-Resistance	R <sub>ON</sub>	-	110	155	mΩ	I <sub>OUT</sub> = 500mA	
Reverse Leak Current	I <sub>REV</sub>	-	-	1.0	μΑ	V <sub>OUT</sub> = 5.0V, V <sub>IN</sub> = 0V	
Over-Current Threshold	I <sub>TH</sub>	820	970	1120	mA		
Short Circuit Output Current	I <sub>sc</sub>	500	650	850	mA	V <sub>OUT</sub> = 0V, RMS	
Output Discharge Resistance	R <sub>DISC</sub>	30	60	120	Ω	I <sub>DISC</sub> = 1mA	
/OC Output Low Voltage	V <sub>/OC</sub>	-	-	0.4	V	I <sub>/OC</sub> = 0.5mA	
UVLO Threshold	$V_{TUVH}$	2.1	2.3	2.5	V	V <sub>IN</sub> Increasing	
OVEO TITESTICIO	$V_{TUVL}$	2.0	2.2	2.4	V	V <sub>IN</sub> Decreasing	

#### **AC Characteristics**

Parameter	Symbol		Limit			Conditions
	Symbol	Min	Тур	Max	Unit	Conditions
Output Rise Time	t <sub>ON1</sub>	-	1	6	ms	$R_L = 20\Omega$
Output Turn ON Time	t <sub>ON2</sub>	-	1.5	10	ms	$R_L = 20\Omega$
Output Fall Time	t <sub>OFF1</sub>	-	1	20	μs	$R_L = 20\Omega$
Output Turn OFF Time	t <sub>OFF2</sub>	-	3	40	μs	$R_L = 20\Omega$
/OC Delay Time	t <sub>/OC</sub>	10	15	20	ms	

# **Electrical Characteristics - continued**

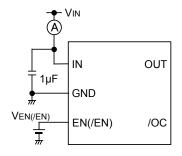
BD2241G ( $V_{IN}$ = 5V, Ta= 25°C, unless otherwise specified.) DC Characteristics

Parameter	Cumbal		Limit		Linit	Conditions	
Parameter	Symbol	Min	Тур	Max	Unit	Conditions	
Operating Current	I <sub>DD</sub>	-	110	160	μA	V <sub>/EN</sub> = 0V, V <sub>OUT</sub> = open	
Standby Current	I <sub>STB</sub>	-	0.01	5	μA	V <sub>/EN</sub> = 5V, V <sub>OUT</sub> = open	
/EN Innut Voltage	V <sub>/ENH</sub>	2.0	-	-	V	High Input	
/EN Input Voltage	V <sub>/ENL</sub>	-	-	0.8	V	Low Input	
/EN Input Leakage	I <sub>/EN</sub>	-1	+0.01	+1	μA	V <sub>/EN</sub> = 0V or 5V	
ON-Resistance	R <sub>ON</sub>	-	110	155	mΩ	I <sub>OUT</sub> = 500mA	
Reverse Leak Current	I <sub>REV</sub>	-	-	1.0	μA	V <sub>OUT</sub> = 5.0V, V <sub>IN</sub> = 0V	
Over-Current Threshold	I <sub>TH</sub>	820	970	1120	mA		
Short Circuit Output Current	I <sub>SC</sub>	500	650	850	mA	V <sub>OUT</sub> = 0V, RMS	
Output Discharge Resistance	R <sub>DISC</sub>	30	60	120	Ω	I <sub>DISC</sub> = 1mA	
/OC Output Low Voltage	V <sub>/OC</sub>	-	-	0.4	V	I <sub>/OC</sub> = 0.5mA	
UVLO Threshold	$V_{TUVH}$	2.1	2.3	2.5	V	V <sub>IN</sub> Increasing	
OVLO Miesnola	$V_{TUVL}$	2.0	2.2	2.4	V	V <sub>IN</sub> Decreasing	

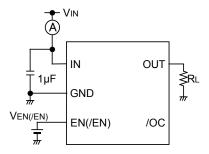
# AC Characteristics

TO Characteriotice						
Parameter	Symbol	Limit			Unit	Conditions
	Symbol	Min	Тур	Max	Offic	Conditions
Output Rise Time	t <sub>ON1</sub>	-	1	6	ms	$R_L = 20\Omega$
Output Turn ON Time	t <sub>ON2</sub>	-	1.5	10	ms	R <sub>L</sub> = 20Ω
Output Fall Time	t <sub>OFF1</sub>	-	1	20	μs	R <sub>L</sub> = 20Ω
Output Turn OFF Time	t <sub>OFF2</sub>	-	3	40	μs	R <sub>L</sub> = 20Ω
/OC Delay Time	t <sub>/OC</sub>	10	15	20	ms	

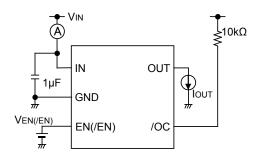
### **Measurement Circuit**



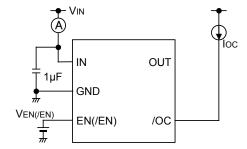
A. Operating Current



B. EN, /EN Input Voltage, Output Rise / Fall Time



C. ON-Resistance, Over-Current Detection



D. /OC Output Low Voltage

Figure 1. Measurement Circuit

# **Timing Diagram**

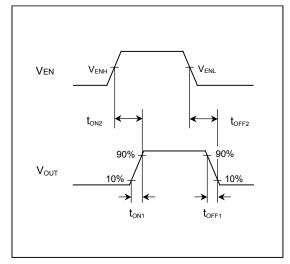


Figure 2. Output Rise / Fall Time (BD2240G)

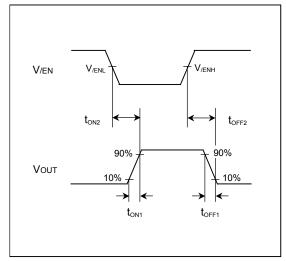


Figure 3. Output Rise / Fall Time (BD2241G)

### **Typical Performance Curves**

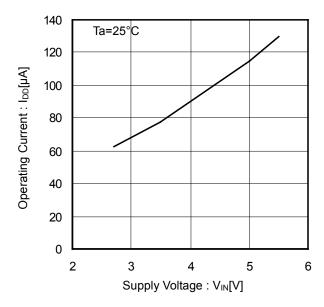


Figure 4. Operating Current vs Supply Voltage (EN, /EN Enable)

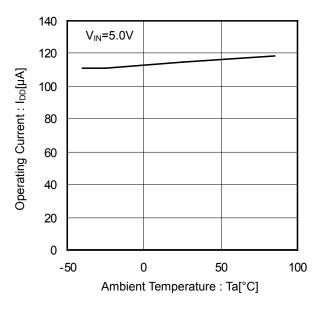


Figure 5. Operating Current vs Ambient Temperature (EN, /EN Enable)

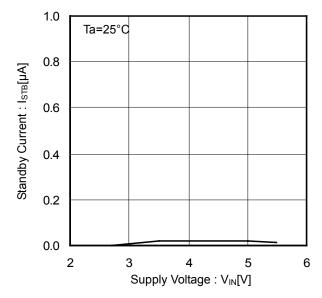


Figure 6. Standby Current vs Supply Voltage (EN, /EN Disable)

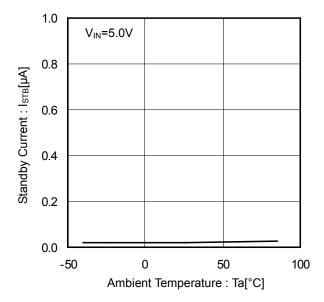


Figure 7. Standby Current vs Ambient Temperature (EN, /EN Disable)

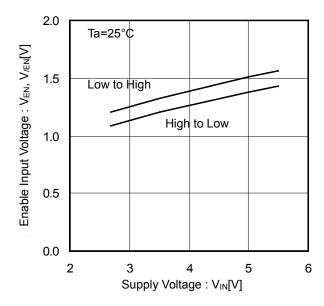


Figure 8. EN, /EN Input Voltage vs Supply Voltage (V<sub>ENH</sub>, V<sub>ENL</sub>, V<sub>/ENH</sub>, V<sub>/ENL</sub>)

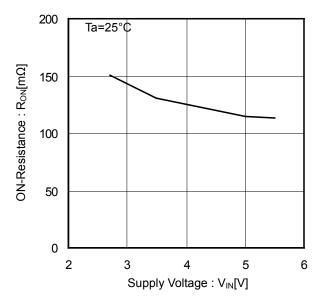


Figure 10. ON-Resistance vs Supply Voltage

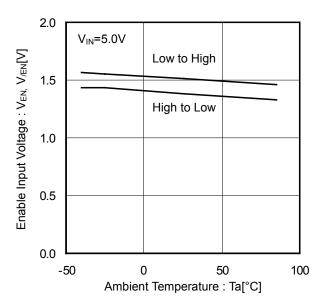


Figure 9. EN, /EN Input Voltage vs Ambient Temperature (V<sub>ENH</sub>, V<sub>ENL</sub>, V<sub>/ENH</sub>, V<sub>/ENL</sub>)

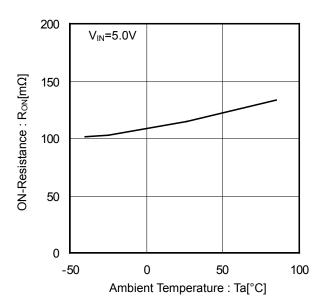


Figure 11. ON-Resistance vs Ambient Temperature

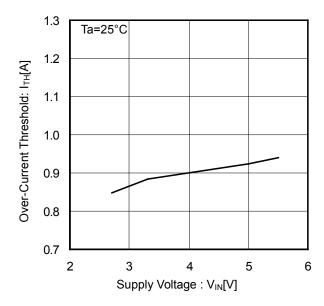


Figure 12. Over-Current Threshold vs Supply Voltage

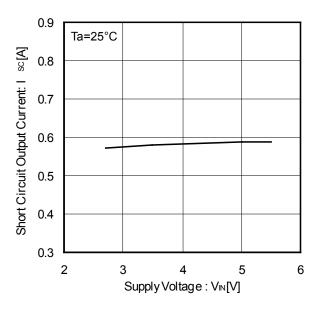


Figure 14. Short Circuit Output Current vs Supply Voltage

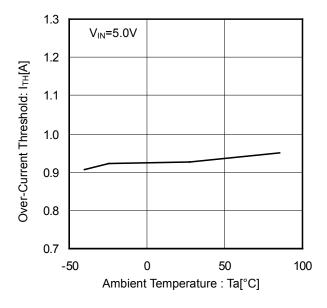


Figure 13. Over-Current Threshold vs Ambient Temperature

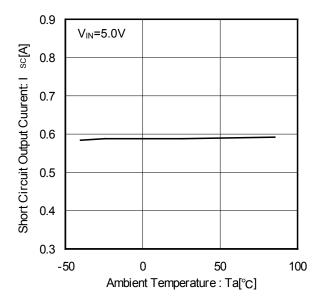


Figure 15. Short Circuit Output Current vs Ambient Temperature

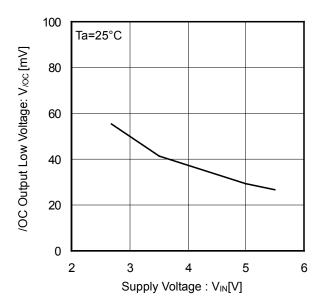


Figure 16. /OC Output Low Voltage vs Supply Voltage

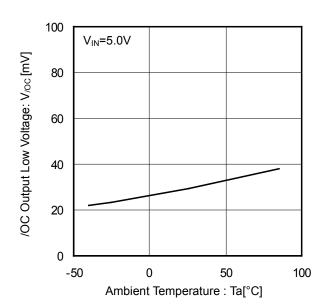


Figure 17. /OC Output Low Voltage vs Ambient Temperature

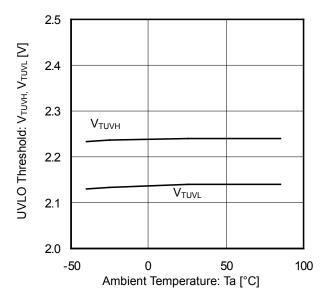


Figure 18. UVLO Threshold Voltage vs Ambient Temperature

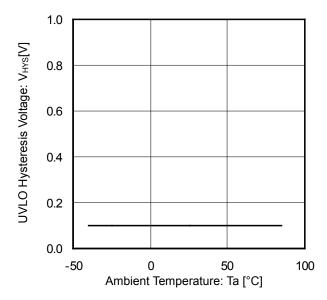


Figure 19. UVLO Hysteresis Voltage vs Ambient Temperature

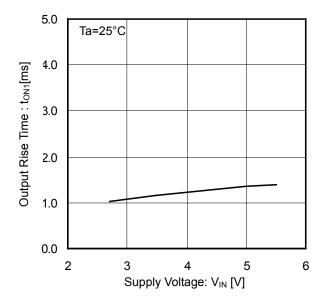


Figure 20. Output Rise Time vs Supply Voltage

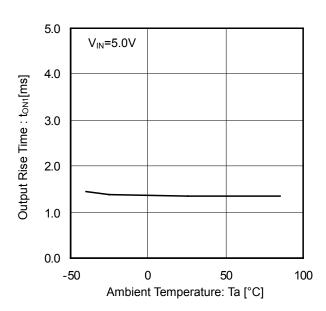


Figure 21. Output Rise Time vs Ambient Temperature

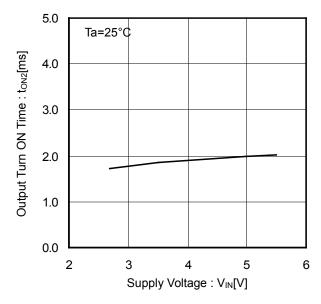


Figure 22. Output Turn ON Time vs Supply Voltage

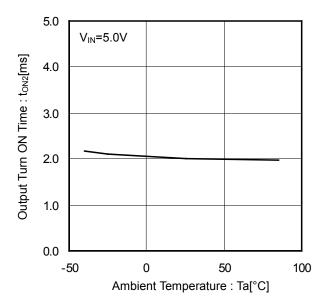


Figure 23. Output Turn ON Time vs Ambient Temperature

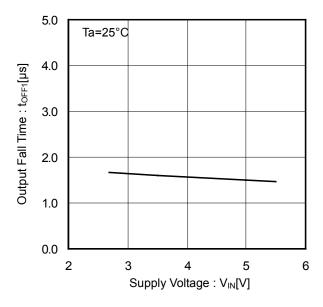


Figure 24. Output Fall Time vs Supply Voltage

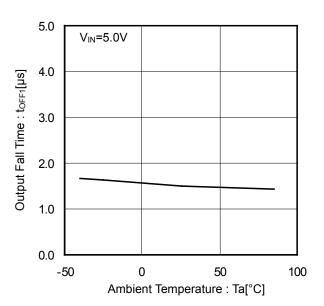


Figure 25. Output Fall Time vs Ambient Temperature

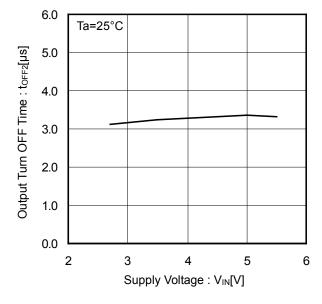


Figure 26. Output Turn OFF Time vs Supply Voltage

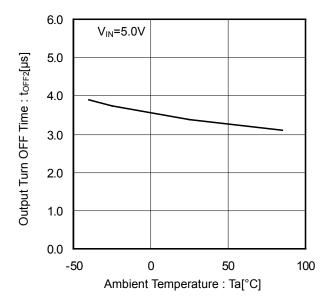


Figure 27. Output Turn OFF Time vs Ambient Temperature

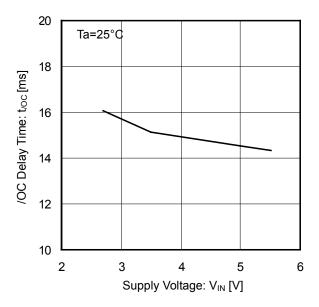


Figure 28. /OC Delay Time vs Supply Voltage

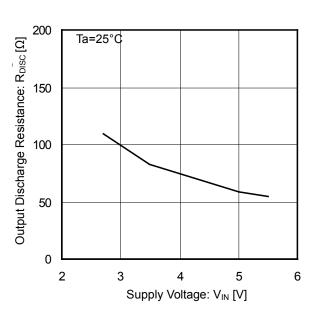


Figure 30. Output Discharge Resistance vs Supply Voltage

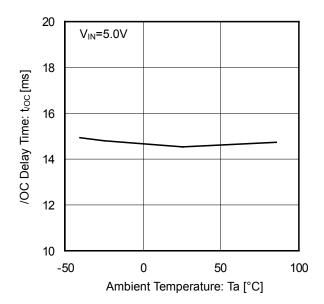


Figure 29. /OC Delay Time vs Ambient Temperature

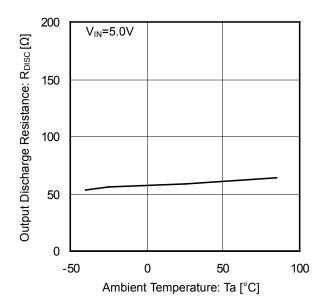


Figure 31. Output Discharge Resistance vs Ambient Temperature

# Typical Wave Forms (BD2240G)

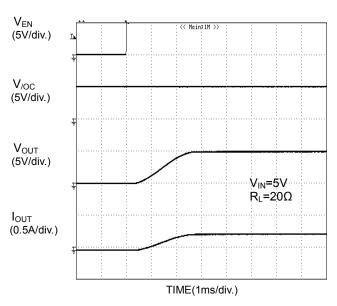


Figure 32. Output Rise Characteristic

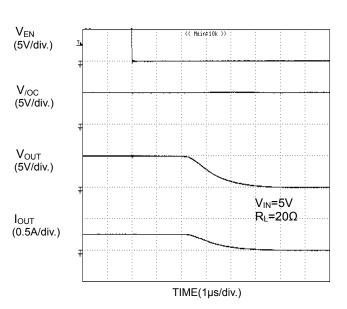


Figure 33. Output Fall Characteristic

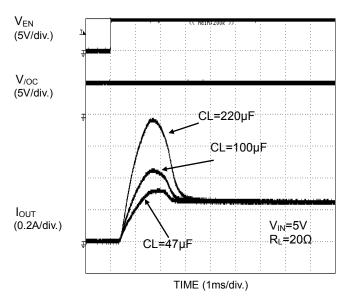


Figure 34. Inrush Current Response

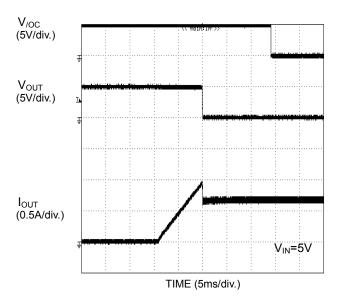


Figure 35. Over-Current Response Ramped Load

# Typical Wave Forms - continued

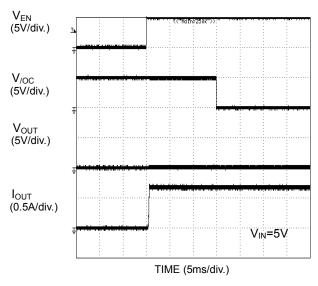


Figure 36. Over-Current Response Enable to Short Circuit

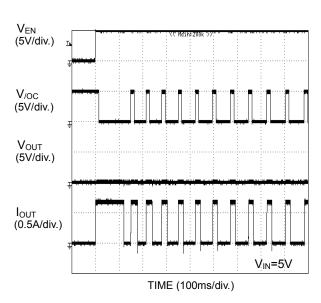


Figure 37. Over-Current Response Enable to Short Circuit

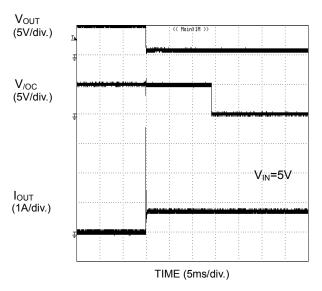


Figure 38. Over-Current Response 1ΩLoad Connected at EN

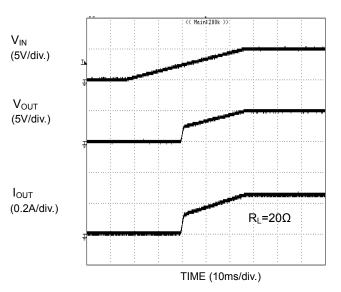


Figure 39. UVLO Response when Increasing  $V_{\text{IN}}$ 

# Typical Wave Forms - continued

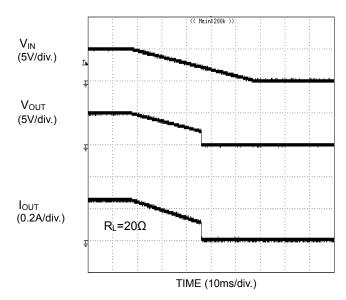
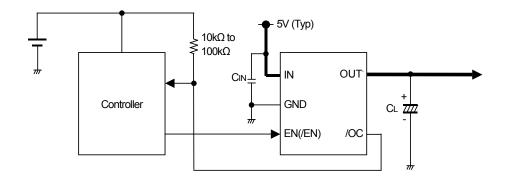


Figure 40. UVLO Response when Decreasing  $V_{\text{IN}}$ 

### **Typical Application Circuit**



### **Application Information**

When excessive current flows due to output short-circuit or so, ringing occurs by inductance of power source line and IC. This may cause bad effects on IC operations. In order to avoid this case, a bypass capacitor ( $C_{IN}$ ) should be connected across the IN terminal and GND terminal of IC. A 1 $\mu$ F or higher value is recommended. Moreover, in order to decrease voltage fluctuations of power source line and IC, connect a low ESR capacitor in parallel with  $C_{IN}$ . A 10 $\mu$ F to 100 $\mu$ F or higher is effective.

Pull up /OC output by resistance  $10k\Omega$  to  $100k\Omega$ .

Set up values for C<sub>L</sub> which satisfies the application.

This application circuit does not guarantee its operation.

When using the circuit with changes to the external circuit constants, make sure to leave an adequate margin for external components including AC/DC characteristics as well as dispersion of the IC.

### **Functional Description**

1. Switch Operation

IN terminal and OUT terminal are connected to the drain and the source of switch MOSFET respectively. The IN terminal is also used as power source input to internal control circuit.

When the switch is turned ON from EN(/EN) control input, the IN and OUT terminals are connected by a  $110m\Omega$  (Typ) switch. In ON status, the switch is bidirectional. Therefore, when the potential of OUT terminal is higher than that of IN terminal, current flows from OUT to IN terminal.

On the other hand, when the switch is turned off, it is possible to prevent current from flowing reversely from OUT to IN terminal since a parasitic diode between the drain and the source of switch MOSFET is not present.

### 2. Thermal Shutdown Circuit (TSD)

If over-current would continue, the temperature of the IC would increase drastically. If the junction temperature goes beyond 135°C (Typ) in the condition of over-current detection, thermal shutdown circuit operates and turns power switch off, causing the IC to output a fault flag (/OC). Then, when the junction temperature decreases lower than 115°C (Typ), the power switch is turned on and fault flag (/OC) is cancelled. This operation repeats, unless the increase of chip's temperature is removed or the output of power switch is turned OFF.

The thermal shutdown circuit operates when the switch is ON (EN(/EN) signal is active).

#### 3. Over-Current Detection (OCD)

The over-current detection circuit limits current ( $I_{SC}$ ) and outputs fault flag (/OC) when current flowing in each switch MOSFET exceeds a specified value. The over-current detection circuit works when the switch is on (EN(/EN) signal is active). There are three types of response against over-current:

- (1) When the switch is turned on while the output is in shortcircuit status

  When the switch is turned on while the output is in shortcircuit status or so, the switch gets in current limit status

  immediately
- (2) When the output shortcircuits while the switch is on When the output shortcircuits or high-current load is connected while the switch is on, very large current will flow until the over-current limit circuit reacts. When the current detection and limit circuit works, current limitation is carried out.
- (3) When the output current increases gradually When the output current increases gradually, current limitation does not work until the output current exceeds the over-current detection value. When it exceeds the detection value, current limitation is carried out.

### 4. Under-Voltage Lockout (UVLO)

UVLO circuit prevents the switch from turning on until the  $V_{IN}$  exceeds 2.3V(Typ). If  $V_{IN}$  drops below 2.2V(Typ) while the switch is still ON, then UVLO shuts off the power switch. UVLO has a hysteresis of 100mV(Typ). Under-voltage lockout circuit operates when the switch is on (EN(/EN) signal is active).

### 5. Fault Flag (/OC) Output

Fault flag output is N-MOS open drain output. During detection of over-current and/or thermal shutdown, the output level will turn low.

Over-current detection has delay filter. This delay filter prevents current detection flags from being sent during instantaneous events such as inrush current at switch on or during hot plug. . If fault flag output is unused, /OC pin should be connected to open or ground line.

#### 6. Output Discharge Function

When the switch is turned off from disable control input or UVLO function, the  $60\Omega(Typ.)$  discharge circuit between OUT and GND turns on. By turning on this switch, electric charge at capacitive load is discharged. But when the voltage of IN declines extremely, then the OUT pin becomes Hi-Z without UVLO function.

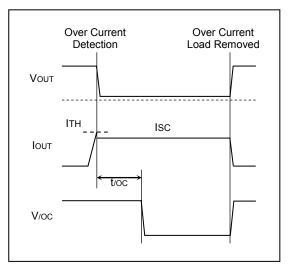


Figure 41. Over-Current Detection

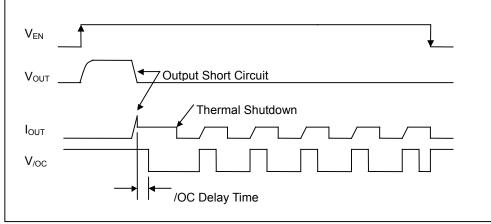


Figure 42. Over-Current Detection, Thermal Shutdown Timing (BD2240G)

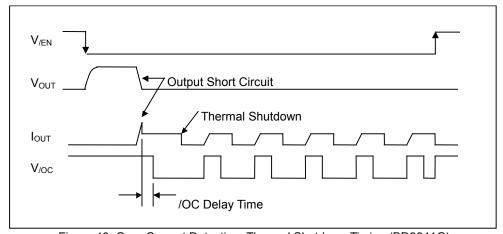
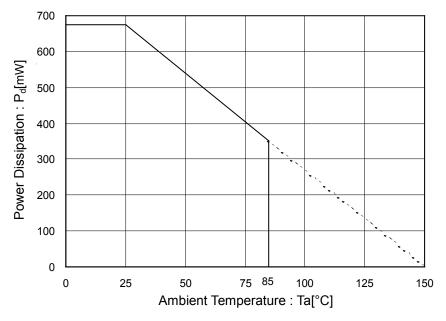


Figure 43. Over-Current Detection, Thermal Shutdown Timing (BD2241G)

# **Power Dissipation**

(SSOP5 package)



70mm x 70mm x 1.6mm Glass Epoxy Board

Figure 44. Power Dissipation Curve (Pd-Ta Curve)

# I/O Equivalence Circuit

Symbol	Pin No.	Equivalence Circuit
EN (/EN)	3	EN (/EN)
OUT	5	OUT
/OC	4	JOC JOC

Downloaded from: http://www.datasheetcatalog.com/

### **Operational Notes**

### 1. Reverse Connection of Power Supply

Connecting the power supply in reverse polarity can damage the IC. Take precautions against reverse polarity when connecting the power supply, such as mounting an external diode between the power supply and the IC's power supply pins.

### 2. Power Supply Lines

Design the PCB layout pattern to provide low impedance supply lines. Separate the ground and supply lines of the digital and analog blocks to prevent noise in the ground and supply lines of the digital block from affecting the analog block. Furthermore, connect a capacitor to ground at all power supply pins. Consider the effect of temperature and aging on the capacitance value when using electrolytic capacitors.

#### 3. Ground Voltage

Ensure that no pins are at a voltage below that of the ground pin at any time, even during transient condition.

# 4. Ground Wiring Pattern

When using both small-signal and large-current ground traces, the two ground traces should be routed separately but connected to a single ground at the reference point of the application board to avoid fluctuations in the small-signal ground caused by large currents. Also ensure that the ground traces of external components do not cause variations on the ground voltage. The ground lines must be as short and thick as possible to reduce line impedance.

### 5. Thermal Consideration

Should by any chance the power dissipation rating be exceeded the rise in temperature of the chip may result in deterioration of the properties of the chip. The absolute maximum rating of the Pd stated in this specification is when the IC is mounted on a 70mm x 70mm x 1.6mm glass epoxy board. In case of exceeding this absolute maximum rating, increase the board size and copper area to prevent exceeding the Pd rating.

### 6. Recommended Operating Conditions

These conditions represent a range within which the expected characteristics of the IC can be approximately obtained. The electrical characteristics are guaranteed under the conditions of each parameter.

#### 7. In rush Current

When power is first supplied to the IC, it is possible that the internal logic may be unstable and inrush current may flow instantaneously due to the internal powering sequence and delays, especially if the IC has more than one power supply. Therefore, give special consideration to power coupling capacitance, power wiring, width of ground wiring, and routing of connections.

#### 8. Operation Under Strong Electromagnetic Field

Operating the IC in the presence of a strong electromagnetic field may cause the IC to malfunction.

### 9. Testing on Application Boards

When testing the IC on an application board, connecting a capacitor directly to a low-impedance output pin may subject the IC to stress. Always discharge capacitors completely after each process or step. The IC's power supply should always be turned off completely before connecting or removing it from the test setup during the inspection process. To prevent damage from static discharge, ground the IC during assembly and use similar precautions during transport and storage.

### 10. Inter-pin Short and Mounting Errors

Ensure that the direction and position are correct when mounting the IC on the PCB. Incorrect mounting may result in damaging the IC. Avoid nearby pins being shorted to each other especially to ground, power supply and output pin. Inter-pin shorts could be due to many reasons such as metal particles, water droplets (in very humid environment) and unintentional solder bridge deposited in between pins during assembly to name a few.

### **Operational Notes - continued**

### 11. Unused Input Pins

Input pins of an IC are often connected to the gate of a MOS transistor. The gate has extremely high impedance and extremely low capacitance. If left unconnected, the electric field from the outside can easily charge it. The small charge acquired in this way is enough to produce a significant effect on the conduction through the transistor and cause unexpected operation of the IC. So unless otherwise specified, unused input pins should be connected to the power supply or ground line.

### 12. Regarding the Input Pin of the IC

This monolithic IC contains P+ isolation and P substrate layers between adjacent elements in order to keep them isolated. P-N junctions are formed at the intersection of the P layers with the N layers of other elements, creating a parasitic diode or transistor. For example (refer to figure below):

When GND > Pin A and GND > Pin B, the P-N junction operates as a parasitic diode. When GND > Pin B, the P-N junction operates as a parasitic transistor.

Parasitic diodes inevitably occur in the structure of the IC. The operation of parasitic diodes can result in mutual interference among circuits, operational faults, or physical damage. Therefore, conditions that cause these diodes to operate, such as applying a voltage lower than the GND voltage to an input pin (and thus to the P substrate) should be avoided.

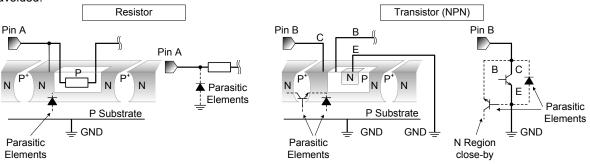


Figure 45. Example of monolithic IC structure

### 13. Ceramic Capacitor

When using a ceramic capacitor, determine the dielectric constant considering the change of capacitance with temperature and the decrease in nominal capacitance due to DC bias and others.

# 14. Thermal Shutdown Circuit(TSD)

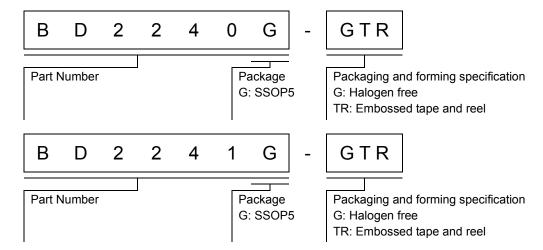
This IC has a built-in thermal shutdown circuit that prevents heat damage to the IC. Normal operation should always be within the IC's power dissipation rating. If however the rating is exceeded for a continued period, the junction temperature (Tj) will rise which will activate the TSD circuit that will turn OFF all output pins. When the Tj falls below the TSD threshold, the circuits are automatically restored to normal operation.

Note that the TSD circuit operates in a situation that exceeds the absolute maximum ratings and therefore, under no circumstances, should the TSD circuit be used in a set design or for any purpose other than protecting the IC from heat damage.

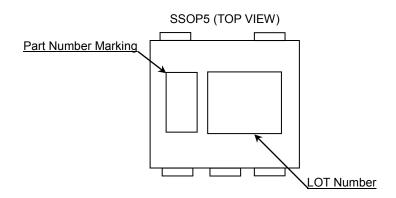
#### 15. Thermal design

Perform thermal design in which there are adequate margins by taking into account the power dissipation (Pd) in actual states of use.

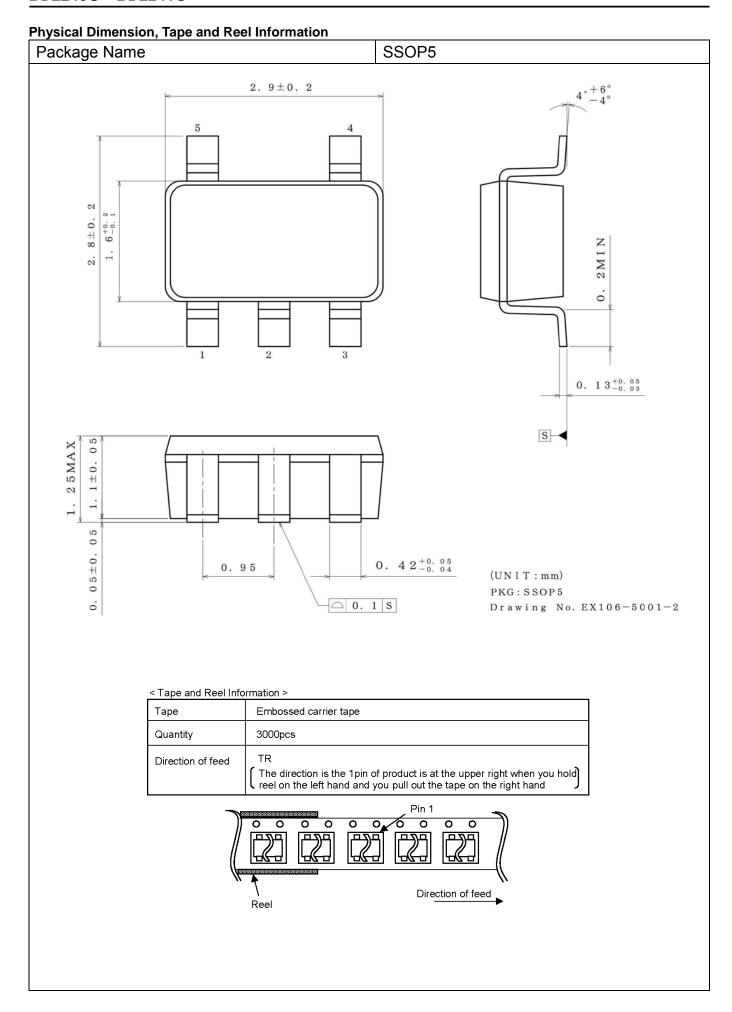
# **Ordering Information**



# **Marking Diagram**



Part Number	Part Number Marking
BD2240G	J8
BD2241G	J9



**Datasheet** 

# **Revision History**

Date	Revision	Changes
11.Mar.2013	001	New Release
16.Apr.2013	002	Ordering information is revised.
21.Aug.2014	003	Applied the ROHM Standard Style and improved understandability. Improved Symbol name. The title of figure 36 changed. Improved Regarding Input Pins of the IC in Operational Notes. Add Figure 14 and 15. Add Output Discharge Function explanation at page17.

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JAPAN	USA	EU	CHINA	
CLASSⅢ	CL ACCTI	CLASSIIb	СГУССШ	
CLASSIV	CLASSⅢ	CLASSⅢ	- CLASSⅢ	

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  - [h] Use of the Products in places subject to dew condensation
- 4. The Products are not subject to radiation-proof design.
- 5. Please verify and confirm characteristics of the final or mounted products in using the Products.
- 6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse. is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7. De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta). When used in sealed area, confirm the actual ambient temperature.
- 8. Confirm that operation temperature is within the specified range described in the product specification.
- 9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

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- 2. In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

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This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of lonizer, friction prevention and temperature / humidity control).

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  - [d] the Products are exposed to high Electrostatic
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